Notice of References Cited Application/Control No. 10/595,795 Applicant(s)/Patent Under Reexamination SCHERMANZ ET AL. Examiner PRITESH DARJI 1793 Applicant(s)/Patent Under Reexamination SCHERMANZ ET AL.

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.